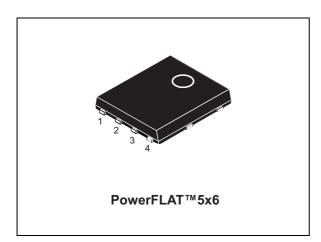
# STL90N3LLH6

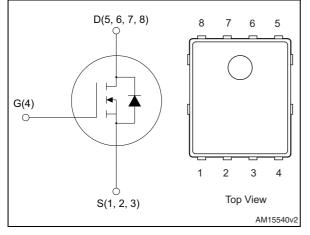
Datasheet - production data



### N-channel 30 V, 0.0038 Ω typ., 24 A STripFET<sup>™</sup> VI DeepGATE<sup>™</sup> Power MOSFET in PowerFLAT<sup>™</sup> 5x6 package



#### Figure 1. Internal schematic diagram



#### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STL90N3LLH6	30 V	0.0045 Ω	24 A (1)

- 1. The value is rated according  $R_{thj-pcb}$
- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power losses
- Very low switching gate charge

### **Applications**

• Switching applications

### Description

This device is an N-channel Power MOSFET developed using the 6<sup>th</sup> generation of STripFET<sup>TM</sup> DeepGATE<sup>TM</sup> technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest  $R_{DS(on)}$  in all packages.

#### Table 1. Device summary

Order code Marking		Packages	Packaging
STL90N3LLH6	90N3LLH6	PowerFLAT™ 5x6	Tape and reel

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This is information on a product in full production.

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3	Test circuits	8
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5	Revision history1	5



## 1 Electrical ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	30	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	90	A
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 70 °C	67.5	А
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	56.2	A
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 25 °C	24	A
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 70 °C	18	А
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> =100 °C	15	А
I <sub>DM</sub> <sup>(2) (3)</sup>	Drain current (pulsed)	96	Α
I <sub>DM</sub> <sup>(1) (3)</sup>	Drain current (pulsed)	360	А
P <sub>TOT</sub> <sup>(1)</sup>	Total dissipation at $T_{C} = 25 \text{ °C}$	60	W
P <sub>TOT</sub> <sup>(2)</sup>	Total dissipation at T <sub>pcb</sub> = 25 °C	4	W
	Derating factor	0.03	W/°C
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150	°C

1. The value is rated according to  $R_{thj-c}$ 

2. The value is rated according to  ${\sf R}_{thj\text{-}pcb}$ 

3. Pulse width limited by safe operating area

#### Table 3. Thermal resistance

Symbol Parameter		Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case (drain, steady state)	2.08	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup> Thermal resistance junction-ambient		31.3	°C/W

1. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu, t < 10 sec

#### Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>J</sub> = 25 °C, I <sub>D</sub> = 12 A; L= 1.25mH)	90	mJ



## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0$	30			V
	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 30 V,			1	μΑ
		V <sub>DS</sub> = 30 V T <sub>C</sub> = 125 °C			10	μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	1	1.7	2.5	V
P	Static drain-source on-	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A		0.0038	0.0045	Ω
R <sub>DS(on)</sub>	resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 12 A		0.0057	0.0073	Ω

Table	5.	On/off	states
-------	----	--------	--------

#### Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		1350	1690	2030	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f=1 MHz,	230	290	350	pF
C <sub>rss</sub>	Reverse transfer capacitance	V <sub>GS</sub> =0	140	176	210	pF
Qg	Total gate charge	$V_{DD}$ =15 V, I <sub>D</sub> = 24 A V <sub>GS</sub> =4.5 V (see Figure 14)		17		nC
Q <sub>gs</sub>	Gate-source charge			8		nC
Q <sub>gd</sub>	Gate-drain charge			6		nC
R <sub>G</sub>	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	1.25	1.7	2	Ω

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> =15 V, I <sub>D</sub> = 12 A, R <sub>G</sub> =4.7 Ω, V <sub>GS</sub> =10 V (see Figure 13)	-	9.5	-	ns
t <sub>r</sub>	Rise time		-	30	-	ns
t <sub>d(off)</sub>	Turn-off delay time		-	37	-	ns
t <sub>f</sub>	Fall time		-	12	-	ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		24	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		96	А
$V_{SD}^{(2)}$	Forward on voltage	I <sub>SD</sub> = 24 A, V <sub>GS</sub> =0	-		1.1	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 12 A,	-	24		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/µs,	-	16.8		nC
I <sub>RRM</sub>	Reverse recovery current	V <sub>DD</sub> =25 V	-	1.4		А

Table 8. Source drain diode

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300µs, duty cycle 1.5%



### 2.1 Electrical characteristics (curves)

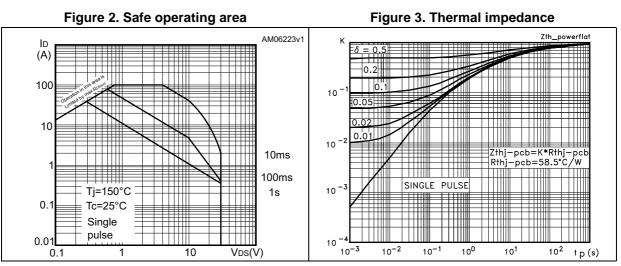


Figure 4. Output characteristics

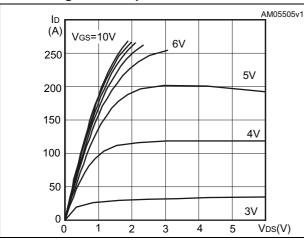


Figure 6. Normalized BV<sub>DSS</sub> vs temperature

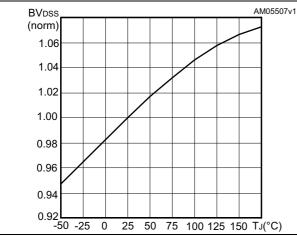
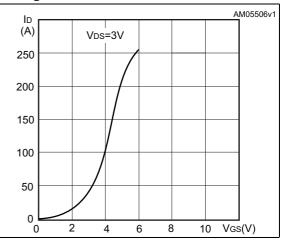
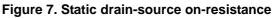


Figure 5. Transfer characteristics





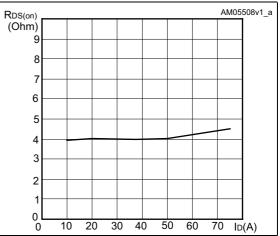




Figure 8. Gate charge vs gate-source voltage

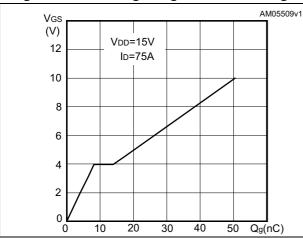


Figure 10. Normalized gate threshold voltage vs temperature

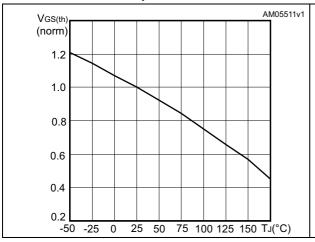
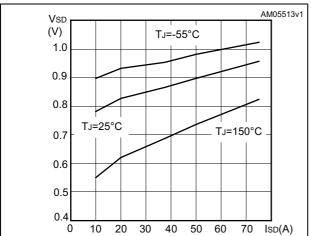


Figure 12. Source-drain diode forward characteristics



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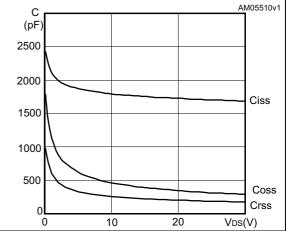
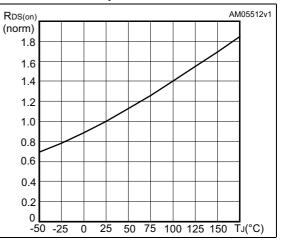


Figure 11. Normalized on-resistance vs temperature



#### 3 **Test circuits**

Figure 13. Switching times test circuit for resistive load

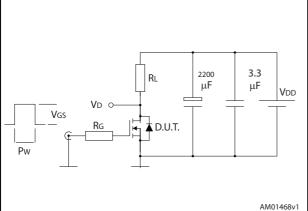


Figure 15. Test circuit for inductive load switching and diode recovery times

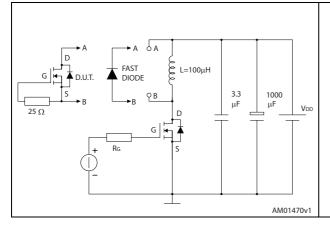
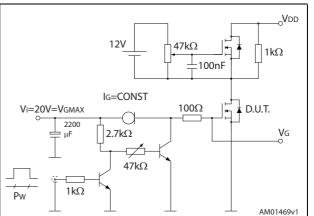
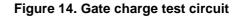


Figure 17. Unclamped inductive waveform

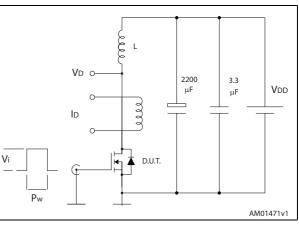
lр

V(BR)DSS









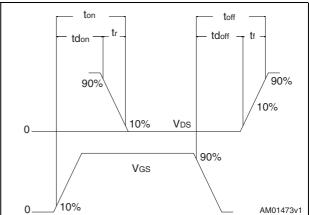
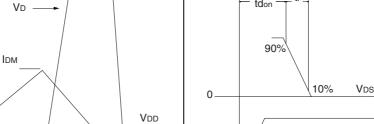


Figure 18. Switching time waveform



AM01472v1



Vdd

### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.



Dim. —	mm			
	Min.	Тур.	Max.	
А	0.80	0.83	0.93	
A1	0	0.02	0.05	
A3		0.20		
b	0.35	0.40	0.47	
D		5.00		
D1		4.75		
D2	4.15	4.20	4.25	
E		6.00		
E1		5.75		
E2	3.43	3.48	3.53	
E4	2.58	2.63	2.68	
е		1.27		
L	0.70	0.80	0.90	

Table 9. PowerFLAT™ 5x6 type C-B mechanical data



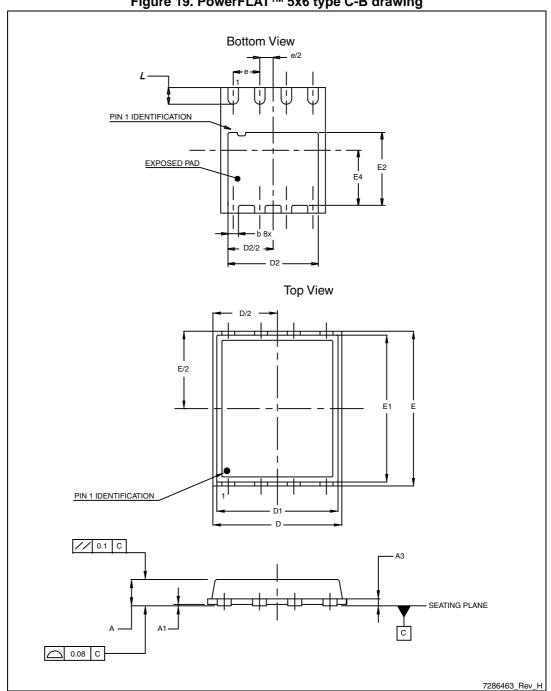


Figure 19. PowerFLAT™ 5x6 type C-B drawing



Table 10. Fowert LAT 5X0 type 3-C mechanical data					
Dim.	mm				
	Min.	Тур.	Max.		
А	0.80		1.00		
A1	0.02		0.05		
A2		0.25			
b	0.30		0.50		
D		5.20			
E		6.15			
D2	4.11		4.31		
E2	3.50		3.70		
е		1.27			
e1		0.65			
L	0.715		1.015		
К	1.05		1.35		



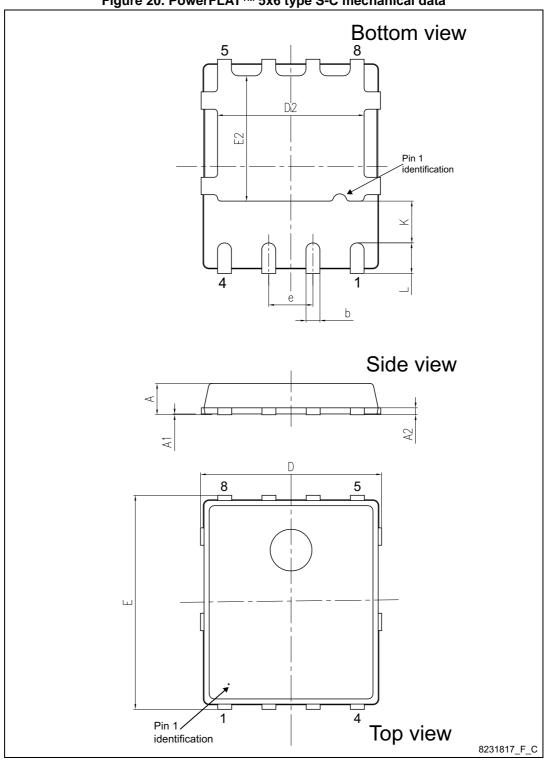


Figure 20. PowerFLAT™ 5x6 type S-C mechanical data



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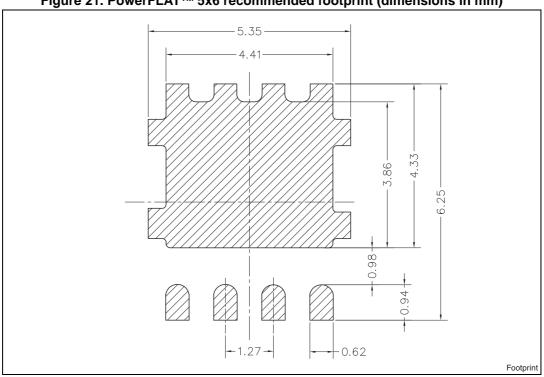


Figure 21. PowerFLAT™ 5x6 recommended footprint (dimensions in mm)



## 5 Revision history

Date	Revision	Changes
10-Apr-2009	1	First release
17-Mar-2010	2	<ul> <li>Inserted new values on <i>Table 5</i>, <i>Table 6</i> and <i>Table 8</i></li> <li>Document status promoted from preliminary data to datasheet.</li> </ul>
10-Nov-2011	3	Inserted I <sub>D</sub> value @ 70 °C, in <i>Table 2: Absolute maximum ratings</i> . <i>Section 4: Package mechanical data</i> has been updated. Minor text changes.
03-Sep-2013	4	<ul> <li>Updated: title and <i>Figure 1</i> in the cover page.</li> <li>Updated: Section 4: Package mechanical data</li> <li>Updated: Figure 13, 14, 15 and 16</li> <li>Added new Table 4: Avalanche characteristics.</li> <li>Minor text changes</li> <li>Document status promoted from preliminary to production data.</li> </ul>

Table 11. Document revision histo	ory
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